

# MOS FIELD EFFECT TRANSISTOR μ**ΡΑ1816**

## P-CHANNEL MOS FIELD EFFECT TRANSISTOR FOR SWITCHING

#### DESCRIPTION

The  $\mu$ PA1816 is a switching device which can be driven directly by a 1.8 V power source.

This device features a low on-state resistance and excellent switching characteristics, and is suitable for applications such as power management of notebook computers and so on.

#### **FEATURES**

- 1.8 V drive available
- Low on-state resistance  $R_{DS(on)1} = 15 \text{ m}\Omega \text{ MAX.}$  (Vgs = -4.5 V, ID = -4.5 A)  $R_{DS(on)2} = 16 \text{ m}\Omega \text{ MAX.} (V_{GS} = -4.0 \text{ V}, \text{ ID} = -4.5 \text{ A})$  $R_{DS(on)3} = 22.5 \text{ m}\Omega \text{ MAX}. (V_{GS} = -2.5 \text{ V}, I_{D} = -4.5 \text{ A})$  $R_{DS(on)4} = 41.5 \text{ m}\Omega \text{ MAX.}$  (Vgs = -1.8 V, ID = -2.5 A)
- Built-in G-S protection diode against ESD

#### ORDERING INFORMATION

PART NUMBER	PACKAGE
μPA1816GR-9JG	Power TSSOP8

#### ABSOLUTE MAXIMUM RATINGS ( $T_A = 25^{\circ}C$ )

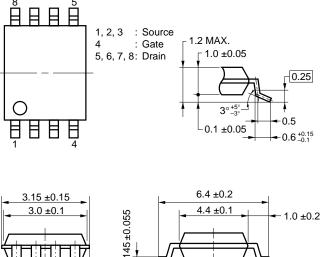
Drain to Source Voltage (VGs = 0 V)	Vdss	-12	V
Gate to Source Voltage (VDS = 0 V)	Vgss	∓8.0	V
Drain Current (DC) (T <sub>A</sub> = 25°C)	ID(DC)	∓9.0	А
Drain Current (pulse) Note1	D(pulse)	<b>∓</b> 36	А
Total Power Dissipation Note2	Р⊤	2.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	–55 to +150	°C

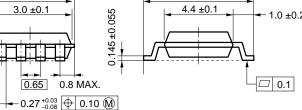
#### **Notes 1.** PW $\leq$ 10 $\mu$ s, Duty Cycle $\leq$ 1%

- 2. Mounted on ceramic substrate of 5000 mm<sup>2</sup> x 1.1 mm
- Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

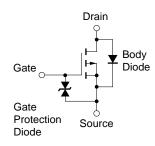
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### PACKAGE DRAWING (Unit: mm)





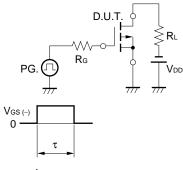
#### EQUIVALENT CIRCUIT



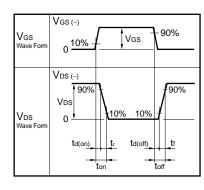
ELECTRICAL CHARACTERISTICS (TA = 25°C)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	$V_{DS} = -12 V, V_{GS} = 0 V$			-1.0	μA
Gate Leakage Current	lgss	$V_{GS} = \mp 8.0 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			<b>∓</b> 10	μA
Gate Cut-off Voltage	V <sub>GS(off)</sub>	$V_{DS} = -10 \text{ V}, \text{ I}_{D} = -1.0 \text{ mA}$	-0.45	-0.75	-1.5	V
Forward Transfer Admittance	y <sub>fs</sub>	$V_{DS} = -10 \text{ V}, \text{ I}_{D} = -4.5 \text{ A}$	11	22		S
Drain to Source On-state Resistance	RDS(on)1	$V_{GS} = -4.5 \text{ V}, \text{ ID} = -4.5 \text{ A}$		12.0	15	mΩ
	RDS(on)2	$V_{GS} = -4.0 \text{ V}, \text{ Id} = -4.5 \text{ A}$		12.5	16	mΩ
	RDS(on)3	$V_{GS} = -2.5 \text{ V}, \text{ ID} = -4.5 \text{ A}$		16.2	22.5	mΩ
	RDS(on)4	Vgs = −1.8 V, Id = −2.5 A		23.7	41.5	mΩ
Input Capacitance	Ciss	V <sub>DS</sub> = -10 V		1570		pF
Output Capacitance	Coss	Vgs = 0 V		400		pF
Reverse Transfer Capacitance	Crss	f = 1.0 MHz		240		pF
Turn-on Delay Time	td(on)	$V_{DD} = -10 \text{ V}, \text{ Id} = -4.5 \text{ A}$		16		ns
Rise Time	tr	Vgs = -4.0 V		132		ns
Turn-off Delay Time	td(off)	Rg = 10 Ω		223		ns
Fall Time	tr			295		ns
Total Gate Charge	QG	$V_{DD} = -10 V$		15		nC
Gate to Source Charge	QGS	Vgs = -4.0 V		3.0		nC
Gate to Drain Charge	Qgd	ID = -9.0 A		4.5		nC
Body Diode Forward Voltage	VF(S-D)	IF = 9.0 A, VGS = 0 V		0.82		V
Reverse Recovery Time	trr	IF = 9.0 A, VGS = 0 V		490		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/ μs		580		nC

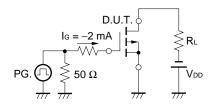
#### **TEST CIRCUIT 1 SWITCHING TIME**



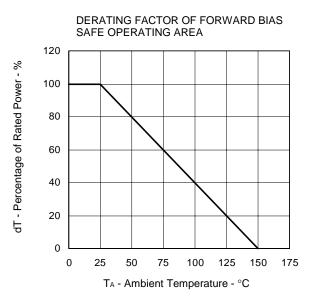
 $\tau = 1 \, \mu s$ Duty Cycle  $\leq 1\%$ 



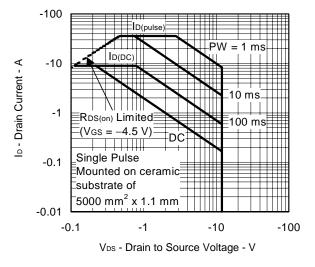
#### TEST CIRCUIT 2 GATE CHARGE

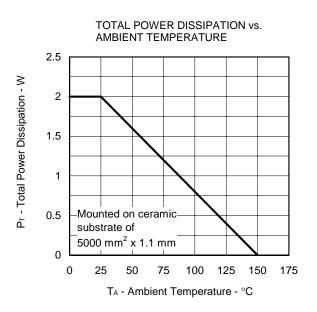


#### TYPICAL CHARACTERISTICS ( $T_A = 25^{\circ}C$ )

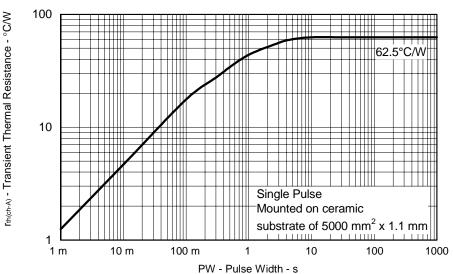


FORWARD BIAS SAFE OPERATING AREA

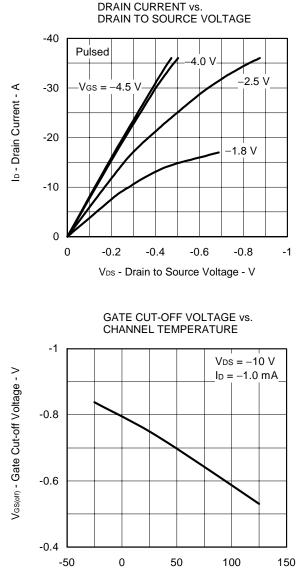




TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

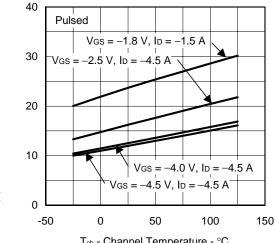


Data Sheet G16252EJ1V0DS



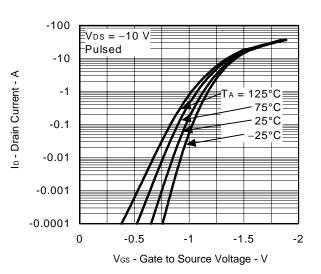
Tch - Channel Temperature - °C



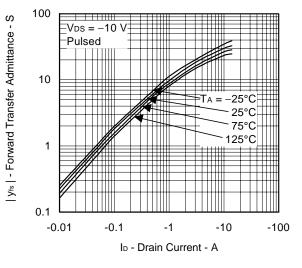




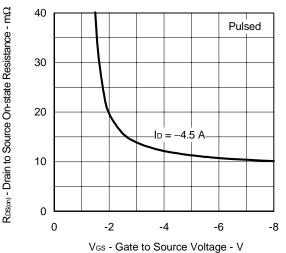
FORWARD TRANSFER CHARACTERISTICS



FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

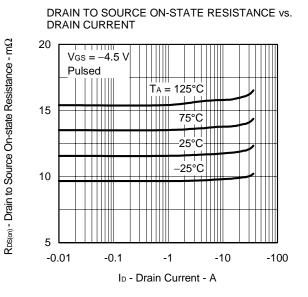


DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

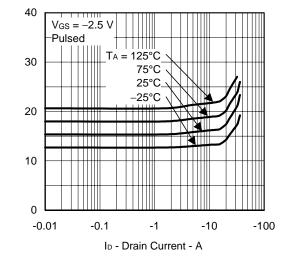


 $R_{DS(m)}$  - Drain to Source On-state Resistance - m $\Omega$ 

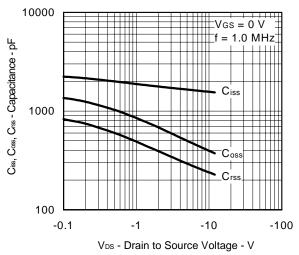
 $R_{DS(on)}$  - Drain to Source On-state Resistance - m $\Omega$ 



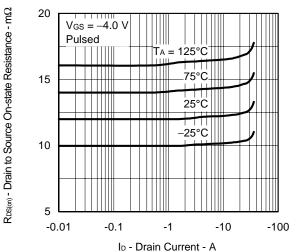
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



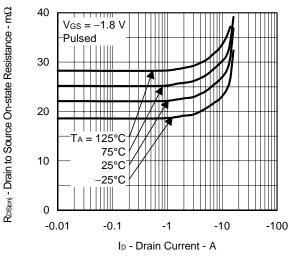


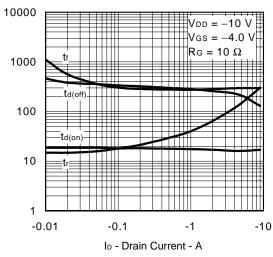


DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

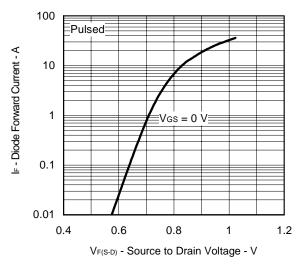




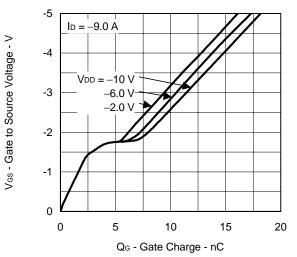
SWITCHING CHARACTERISTICS

td(on), tr, td(off), tr - Switching Time - ns

SOURCE TO DRAIN DIODE FORWARD VOLTAGE



DYNAMIC INPUT/OUTPUT CHARACTERISTICS



[MEMO]

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